

### N-Channel 500V MOSFET

### **Description**

The MSF5N50 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The ITO-220AB package is universally preferred for all commercial-industrial applications

#### **Features**

- Low On Resistance
- · Simple Drive Requirement
- · Low Gate Charge
- Fast Switching Characteristic
- RoHS compliant / Halogen free package available

#### Application (500V-600V)

- Open Framed Power Supply
- Adapter
- STB

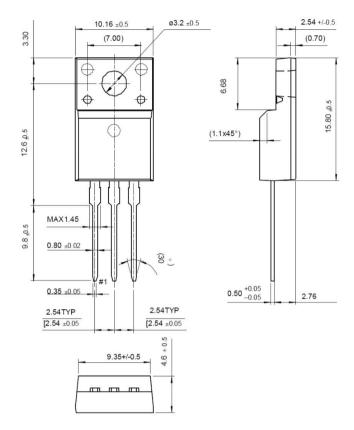
Package type: ITO220-AB

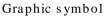
Packing & Order Information

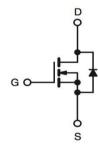
50/Tube; 1,000/Box











#### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Unit		
$V_{DSS}$	Drain-Source Voltage	500	V		
$V_{GS}$	Gate-Source Voltage	±30	V		
$I_D$	Continuous Drain Current (@ TC=25°C)	4.5	A		
	Continuous Drain Current (@ TC=100°C)	2.9	A		
$I_{DM}$	Pulsed Drain Current	18	A		
I <sub>AR</sub>	Avalanche Current	4.5	A		
Eas	Single Pulsed Avalanche Energy	270	mJ		
Ear	Repetitive Avalanche Energy	7.3	mJ		
dv/dt	Peak Diode Recovery dv/dt	5.5	V/ns		



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Absolute Maximum Ratings					
Symbol	Parameter	Value	Unit		
$P_D$	Power Dissipation (TC=25°C)	38	W		
	Power Dissipation (TC=100°C)	0.3	W/°C		
$T_{STG}$	Operating and Storage Temperature Range	-55 to +150	°C		

#### NOTE:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2.  $I_{AS}$ =4.5A,  $V_{DD}$ =50V,  $R_{G}$ =25 $\Omega$ , Starting TJ =25 $^{\circ}$ C
- 3.  $I_{SD}$ ≤4.5A, di/dt≤300A/ $\mu$ s, VDD≤BVDSS , Starting TJ =25 °C
- 4. Pulse Test : Pulse Width ≤ 300µs, Duty Cycle ≤ 2%
- 5. Essentially Independent of Operating Temperature

Static Characte	eris tic s				
Symbol	Test Conditions	Min	Тур.	Max.	Units
$ m V_{GS}$	$V_{\mathrm{DS}} = V_{\mathrm{GS}},  \mathrm{I}_{\mathrm{D}} = 250 \mu A$	2.0		4.0	V
*R <sub>DS(ON)</sub>	$V_{GS} = 10 \text{ V}, I_D = 2.25 \text{ A}$		1.2	1.5	mΩ
$BV_{DSS}$	$V_{GS}=0~V$ , $I_D=250\mu A$	500			V
$\Delta BV_{DSS}/\Delta T_J$	$I_D = 250 \mu A$ , Referenced to $25^{\circ} \mathrm{C}$		0.4		V/°C
$I_{DSS}$	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$			10	uA
IDSS	$V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_j = 125 ^{\circ}\text{C}$			100	
$I_{GSSF}$	$V_{DS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
$I_{GSSR}$	$V_{DS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA

Dynamic Characteristics					
Symbol	Test Conditions	Min	Тур.	Max.	Units
$Q_{\mathrm{g}}$	$V_{DS} = 400 \text{ V}, I_D = 4.5 \text{ A},$ $V_{GS} = 10 \text{ V}$		14	18	nC
$Q_{gs}$			2.5		nC
$Q_{\mathrm{gd}}$			6		nC
$t_{d(on)}$			20	40	ns
$t_{\rm r}$	$V_{DS} = 250 \text{ V}, I_D = 2.5 \text{ A},$		25	50	ns
$t_{d(off)}$	$R_G = 25 \Omega$		45	90	ns
tf			25	50	ns
Ciss	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{MHz}$		550	720	pF
Coss			80	105	pF
$C_{RSS}$			10	13	pF



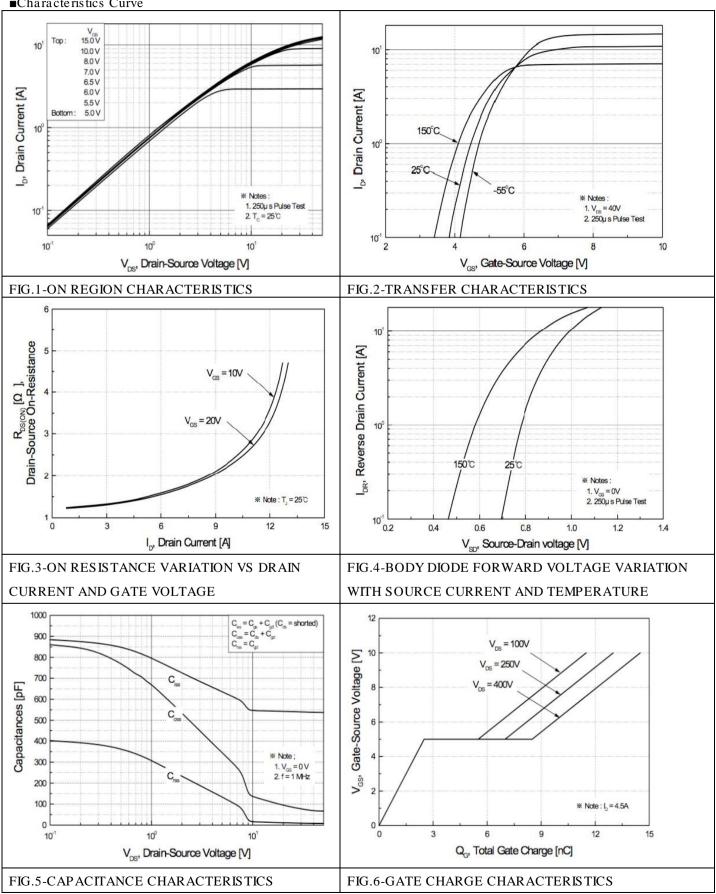
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Source-Drain Diode Characteristics					
Symbol	Test Conditions	Min	Тур.	Max.	Units
$I_S$				4.5	
I <sub>SM</sub>				18	A
$V_{\mathrm{SD}}$	$I_S = 4.5 A$ , $V_{GS} = 0 V$			1.5	V
$t_{rr}$	1 45 A W 0 W 415/44-400A/w		250		ns
Qrr	$I_{S}=4.5~A$ , $V_{GS}=0~V$ , dIF/dt=100A/ $\mu$ s		2.2		uC



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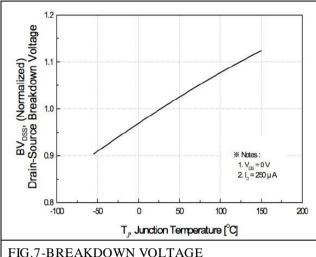
#### ■Characteristics Curve





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### ■Characteristics Curve



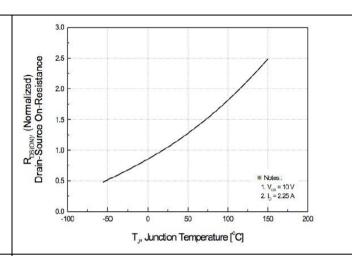


FIG.7-BREAKDOWN VOLTAGE VARIATION VS TEMPERATURE

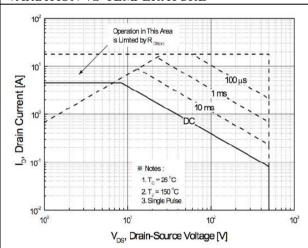


FIG.8-ON-RESISTANCE VARIATION VS TEMPERATURE

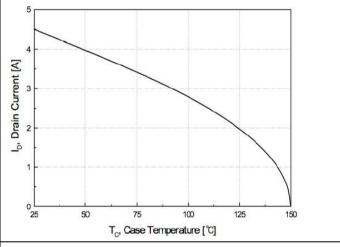


FIG.9-MAXIMUM SAFE OPERATING AREA

 $\begin{aligned} & \textbf{FIG.10-MAXIMUM DRAIN CURRENT VS CASE} \\ & \textbf{TEMPERATURE} \end{aligned}$ 

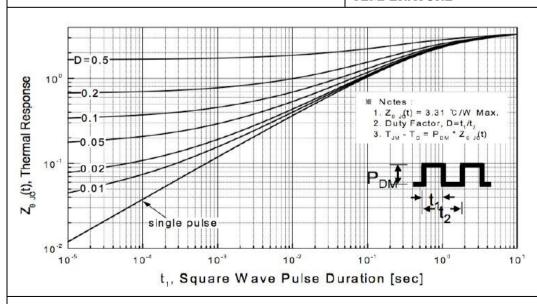


FIG.11-TRANSIENT THERMAL RESPONSE CURVE



### N-Channel 500V MOSFET

■Characteristics Test Circuit & Waveform

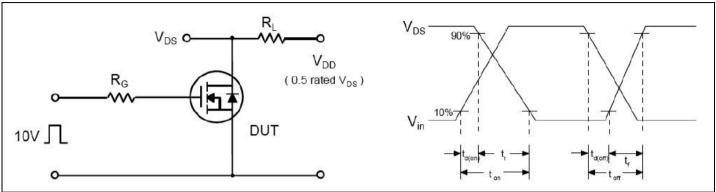


Fig 12. Resistive Switching Test Circuit & Waveforms

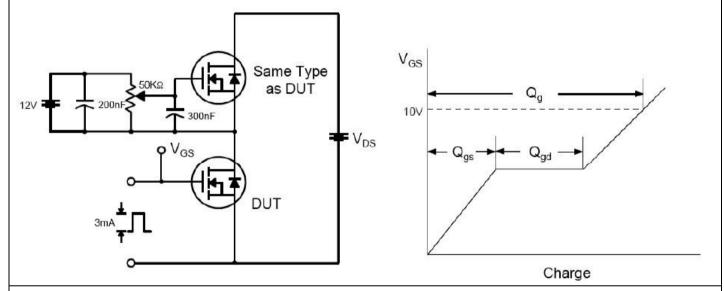


Fig 13. Gate Charge Test Circuit & Waveform

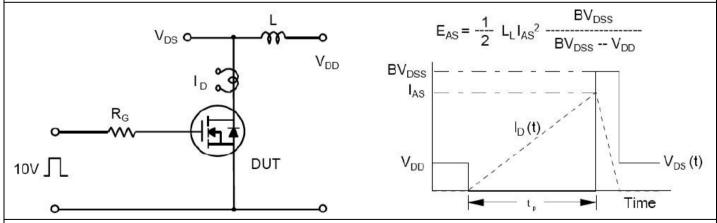


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



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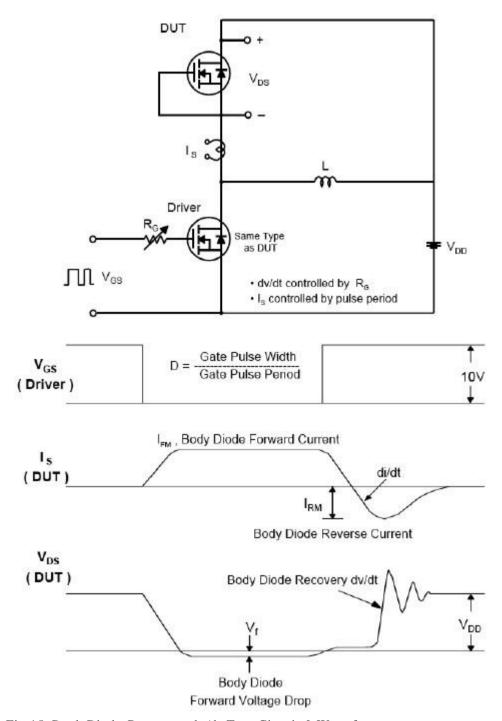


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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